

Search Notes



Application/Control No.

10/798,626

Examiner

Betsey M. Hoey

Applicant(s)/Patent under Reexamination

ZHANG, WEI-XIAN

Art Unit

1724

SEARCHED

Class	Subclass	Date	Examiner
210	747		
405	128.1		
	128.5		
252	175		
588	901	6/16/05	BMTB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
inventor name	6/16/05	BMTB